

<b>Notice of References Cited</b>	Application/Control No. 09/973,616	Applicant(s)/Patent Under Reexamination MARTINEZ, DAVID FREDERIC	
	Examiner Paul W Myers	Art Unit 2612	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0198755 ✓	12-2002	Birkner et al.	705/8
	B	US-2002/0039115 ✓	04-2002	Kawashima, Iwao	345/810
	C	US-2003/0011684 ✓	01-2003	NARAYANASWAMI et al.	348/207.99
	D	US-2002/0103818 ✓	08-2002	Amberden, Bruce	707/205
	E	US-2003/0063208 ✓	04-2003	Kazami, Kazuyuki	348/333.13
	F	US-6,336,073 ✓	01-2002	Ihara et al.	701/202
	G	US-5,926,116 ✓	07-1999	Kitano et al.	340/988
	H	US-6,456,729 ✓	09-2002	Moore, Lewis J.	382/103
	I	US-6,621,524 ✓	09-2003	Iijima et al.	348/584
	J	US-2002/0093583 ✓	07-2002	Ito, Takeyoshi	348/373
	K	US-2002/0056114 ✓	05-2002	Fillebrown et al.	725/78
	L	US-2002/0087546 ✓	07-2002	Slater et al.	707/10
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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